

# Search Notes



Application/Control No.

10/510,501

Examiner

Sang Y. Paik

Applicant(s)/Patent under  
Reexamination

SHIMIZU ET AL.

Art Unit

3742

## SEARCHED

Class	Subclass	Date	Examiner
392	386		
	390		
	391		
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	393		
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	395		
	438		
	429		
	432		
	433		
239	34		
	35		
422	1		
	12	9/18/05	SP
updated		12/23/05	SP

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
A7	ABWE	12/23/05	SP

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
CPA 76A SEARCHED	9/18/05	SP